Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/790,657	KEKRE ET AL.
Examiner	Art Unit
JEAN B. FLEURANTIN	2162

SEARCHED					
Class	Subclass	Date	Examiner		
707	1-10	2/19/2007	JBF		
707	100-104.1	2/19/2007	JBF		
707	200-206	2/19/2007	JBF		
710	21 33	2/19/2007	JBF		
711	143	2/19/2007	JBF		
711	161 & 162	2/19/2007	JBF		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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		No.		
		等 2		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST (US PG PUB, US PT, EPO, JPO, DERWENT & IBM TDB).	2/19/2007	JBF		
707/ccls & 711/ccls & Inventors Search & all related applications have been reviewed for possible Double Patenting.	2/19/2007	JBF		
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